



FORM PT 449

U.S. DEPARTMENT OF COMMERCE  
PATENT AND TRADEMARK OFFICEATTY. DOCKET NO.  
ACUFO.002DV2APPLICATION NO.  
10/729,018INFORMATION DISCLOSURE STATEMENT  
BY APPLICANT

(USE SEVERAL SHEETS IF NECESSARY)

APPLICANT  
David Miller, et al.FILING DATE  
December 5, 2003GROUP  
2873

## U.S. PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE (IF APPROPRIATE)
EF	1.	3,270,099	08/30/66	CAMP	—	—	
EF	2.	3,507,566	04/21/70	KNAPP	—	—	
EF	3.	3,578,850	05/18/71	GRANT	—	—	
EF	4.	3,726,587	04/10/73	KENDALL	—	—	
EF	5.	3,794,414	02/26/74	WESLEY	—	—	
EF	6.	4,639,105	01/1987	NEEFE	—	—	
EF	7.	4,655,774	04/07/87	CHOYCE	—	—	
EF	8.	4,955,904	09/11/90	ATEBARA ET AL.	—	—	
EF	9.	4,976,732	12/11/90	VOROSMARTHY	—	—	
EF	10.	4,994,080	02/19/91	SHEPARD	—	—	
EF	11.	5,196,026	03/23/93	BARRETT ET AL.	—	—	
EF	12.	5,245,367	09/14/93	MILLER ET AL.	—	—	
EF	13.	5,260,727	11/9/93	OKSMAN ET AL.	—	—	
EF	14.	5,314,961	05/1994	ANTON ET AL.	—	—	
EF	15.	5,662,706	09/02/97	LEGERTON ET AL.	—	—	
EF	16.	5,628,794	05/13/97	LINDSTROM	—	—	
EF	17.	5,757,458	05/26/98	MILLER ET AL.	—	—	
EF	18.	5,786,883	07/28/98	MILLER ET AL.	—	—	
EF	19.	5,864,378	01/26/99	PORTNEY	—	—	
EF	20.	5,905,561	05/18/99	LEE ET AL.	—	—	
EF	21.	5,964,748	10/12/99	PEYMAN	—	—	
EF	22.	5,965,330	10/12/99	EVANS ET AL.	—	—	
EF	23.	5,980,040	11/09/99	XU ET AL.	—	—	
EF	24.	6,090,141	07/18/00	LINDSTROM	—	—	
EF	25.	6,554,424	04/29/03	MILLER ET AL.	—	—	

EXAMINER

DATE CONSIDERED

\*EXAMINER: INITIAL IF CITATION CONSIDERED, WHETHER OR NOT CITATION IS IN CONFORMANCE WITH MPEP 609; DRAW LINE THROUGH CITATION IF NOT IN CONFORMANCE AND NOT CONSIDERED, INCLUDE COPY OF THIS FORM WITH NEXT COMMUNICATION TO APPLICANT.

FORM PTO-1449	U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE	ATTY. DOCKET NO. ACUFO.002DV2	APPLICATION NO. 10/729,018
INFORMATION DISCLOSURE STATEMENT BY APPLICANT  (USE SEVERAL SHEETS IF NECESSARY)		APPLICANT David Miller, et al.	
		FILING DATE December 5, 2003	GROUP 2873

FOREIGN PATENT DOCUMENTS								
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION	
							YES	NO
<i>ef</i>	26.	WO 95/08135	03/23/95	MILLER ET AL.	—	—		
<i>ef</i>	27.	WO 97/48005	18/12/97	LEGERTON ET AL.	—	—		

EXAMINER INITIAL	OTHER DOCUMENTS (INCLUDING AUTHOR, TITLE, DATE, PERTINENT PAGES, ETC.)							
<i>ef</i>	28.	"RESEARCH ON THE MULTI-RANGE LENS," WESLEY, N.K., PAGES 18-24.						
<i>ef</i>	29.	"IMPLANTS WITH COLOURED AND OPAQUE PORTIONS: IMPLANTS WITH BUILT-IN STENOPEIC APERTURE," CHOYCE, P., PAGES 21-26; "UNIOCLAR APHAKIA CORRECTED BY ANTERIOR CHAMBER IMPLANTS WITH BUILT-IN STENOPEIC APERTURE," P. CHOYCE., PAGES 132-136 <u>INTRA-OCULAR LENSES AND IMPLANTS</u> , London, 1964.						
<i>ef</i>	30.	"USE AND INTERPRETATION OF THE PINHOLE TEST", <u>THE OPTOMETRIC WEEKLY</u> , TAKAHASHI, E., PAGES 83-86, 1965.						
<i>ef</i>	31.	"NEW ASPECTS IN THE FITTING OF THE MULTI-RANGE BIFOCAL CONTACT LENS", J.J. GROPP, <u>CONTACTO</u> , VOLUME 15:22-29, 1971.						
<i>ef</i>	32.	"THE CONTROLLED-PUPIL CONTACT LENS IN LOW VISION PROBLEMS", <u>JOURNAL OF THE AMERICAN OPTOMETRIC ASSOCIATION</u> , ROSENBLUM, PAGES 836-840, 1969.						
<i>ef</i>	33.	"HOLES IN CLEAR LENSES DEMONSTRATE A PINHOLE EFFECT", <u>ARCHIVES OF OPHTHALMOLOGY</u> , ZACHARIA ET AL., PAGES 511-513, 1988.						
<i>ef</i>	34.	"QUANTIFICATION OF THE PINHOLE EFFECT", <u>PERSPECTIVES IN REFRACTION</u> , VOLUME 21:347-350, MILLER ET AL., 1977.						
<i>ef</i>	35.	EPO PARTIAL SEARCH REPORT, DATED 08/18/2000, <i>PCT/US00/05136</i>						
<i>ef</i>	36.	PCT/US 00/05136 INTERNATIONAL PRELIMINARY EXAMINATION REPORT, DATED 03/15/01.						
<i>ef</i>	37.	Office Action mailed 6/30/04 in U.S. Application No. 10/384,957 filed 3/10/03.						

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040704

EXAMINER <i>ef</i>	DATE CONSIDERED <i>1/3/05</i>
*EXAMINER: INITIAL IF CITATION CONSIDERED, WHETHER OR NOT CITATION IS IN CONFORMANCE WITH MPEP 609; DRAW LINE THROUGH CITATION IF NOT IN CONFORMANCE AND NOT CONSIDERED, INCLUDE COPY OF THIS FORM WITH NEXT COMMUNICATION TO APPLICANT.	